Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/606,243	HASEGAWA ET AL.	
Examiner	Art Unit	
Leon J. Harper	2166	

SEARCHED					
Class	Subclass	Date	Examiner		
707	102,1,200, 104.1,7	11/21/2005	LJH		
709	225	11/21/2005	LJH		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	<u> </u>		, _		
	<u> </u>				

SEARCH NO (INCLUDING SEARCH	TES STRATEGY))
	DATE	EXMR
consulted with M.ali about prior art	11/23/2005	LJH